



Supplementary material

Self-Catalyzed InSb/InAs Quantum Dot Nanowires

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In order to measure the geometrical parameters, the nanowires (NWs) were mechanically transferred from the as-grown substrates onto a Si substrate and 90° projection SEM images were performed. We measured the following quantities for each sample (averaged over ~ 25 NWs): the length (L_{QD}) and the diameter (D_{QD}) of the InSb QD, the diameter of the NWs specifically around InSb QD (D_{InSb}), the NW total length (L_{NWs}), and its base diameter (D_{bottom}), the base radius (R), the height (H), and contact angle (β) of the nanoparticle (NP) on top of the NWs. In the case of InAs/InSb NWs (without InAs top segment), the measured values of D_{InSb} , D_{bottom} , and L_{NWs} were 70 ± 4 nm, 50 ± 4 nm, and 400 ± 21 nm, respectively. These values are applicable for all the samples of the series.

S1. In As Temperature Series

In Figure S1, we show the plots of D_{InSb} , D_{bottom} and L_{NWs} as a function of T_{InAs} for the series of the sample in which we varied only the growth temperature of InAs top segment (Figure 1 of the main text).

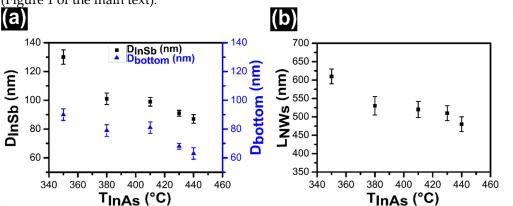


Figure S1. (a) Evolution of the diameter of the NW around the InSb QD and at the bottom versus $T_{InAs.}$ (b) Evolution of total length of NWs (L_{NWs}) as a function of $T_{InAs.}$. The symbols represent an average value of each sample obtained by measuring ~ 25 NWs and error bars represent the standard deviation of the average.

S2. As Line Pressure Series

In Figure S2, we show the plots of D_{InSb} , D_{bottom} and L_{NWs} as a function of As line pressure F_{As} for the series of the sample in which we varied only the As line pressure during the growth of InAs top segment (Figure 2 of the main text).

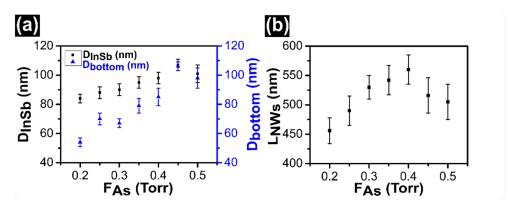


Figure S2. Morphological parameters of InSb/InAs QD NWs, obtained with fixed In line pressure $F_{In} = 0.30$ Torr, growth time 15 min at $T_{InAs} = 440$ °C, while F_{As} varies from 0.20 Torr to 0.50 Torr, (a) Expansion of NW diameter at the InSb QD position and at the bottom of NWs versus F_{As} . (b) Evolution of total length of NWs (L_{NWs}) as a function of F_{As} . The symbols represent an average value of each sample obtained by measuring ~ 25 NWs and error bars represent the standard deviation of the average.

S3. Time Series

In Figure S3, we show the plots of D_{InSb} , D_{bottom} , and L_{NWs} as a function of InAs growth time for the series of the sample in which we varied only the growth time of InAs top segment (Figure 3 of the main text).

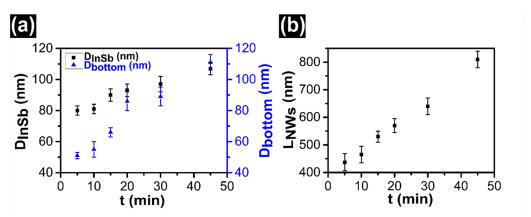


Figure S3. Morphological parameters of InSb/InAs QD NWs, obtained with fixed line pressures $F_{lm} = 0.30$ Torr, $F_{As} = 0.30$ Torr, at $T_{lmAs} = 440$ °C, while the growth time of top InAs segments varies from 5 min to 45 min. (a) Expansion of the NW diameter around the InSb QD and at the bottom of NWs as a function of growth time. (b) Evolution of total length of NWs as a function of growth time. The symbols represent an average value of each sample obtained by measuring ~ 25 NWs and error bars represent the standard deviation of the average.